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In the claims:

1. (Original) A method of maintaining an initial bias of an x-ray detector comprising:

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setting the initial bias of the x-ray detector;

altering an operating state of a readout circuit; and

adjusting a photodiode common contact voltage potential by a data line drift amount to approximately maintain the initial bias.

- 2. (Original) A method as in claim 1 further comprising maintaining scan circuitry in an active state.
- 3. (Original) A method as in claim 1 wherein adjusting a photodiode common contact voltage potential is performed by adjusting said photodiode common contact voltage potential by an amount approximately equal to an average change in a phurality of detector data line voltage potentials.
 - 4. (Original) A method as in claim 1 further comprising:

determining whether conditions for powering down said readout circuit have been satisfied;

powering OFF said readout circuit and adjusting said common contact voltage potential in response to said determination; and

clamping data line voltage potential.

5. (Original) A method as in claim 1 further comprising:

powering ON said readout circuit; and

adjusting said photodiode common contact voltage potential to an initial common contact voltage potential.

 (Original) A method as in claim 1 wherein adjusting said photodiode common contact voltage is performed when a power state of said readout circuit is altered. (Original) A method as in claim 1 further comprising:

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measuring an error signal; and

readjusting said common contact voltage potential when said error signal is above a predetermined level.

8. (Original) A method as in claim 1 of determining data line drift within an x-ray system comprising:

establishing initial bias conditions;

scrubbing at least one detector until said at least one detector reaches equilibrium;

altering operating state of at least one readout circuit without altering a common contact potential; and

measuring data line drift.

- 9. (Original) A method as in claim 8 further comprising determining an average error signal for a plurality of data lines.
- 10. (Original) A method as in claim 8 wherein establishing initial bias conditions, scrubbing at least one detector, and altering operating state is performed via a controller.
 - 11. (Currently Amended) An x-ray imaging system comprising:
 - a detector having a plurality of pixels comprising;
 - at least one data line; and
 - a common contact at a common contact voltage potential;
- a readout circuit electrically coupled to said at least one data line and having a plurality of power states; and
- a controller electrically coupled to said readout circuit, detecting a change in operating state of said readout circuit bias between said at least one data line and said common contact, and adjusting active voltage potential of said common

contact to an active non-zero voltage potential in response to said bias change in operating state.

12. (Currently Amended) A system as in claim 11 An x-ray imaging system comprising:

a detector having a plurality of pixels comprising;

at least one data line; and

a common contact at a common contact voltage potential;

a readout circuit electrically coupled to said at least one data line and having a plurality of power states; and

a controller electrically coupled to said readout circuit, detecting a change in operating state of said readout circuit, and adjusting voltage potential of said common contact in response to said change in operating state;

wherein said controller adjusts voltage potential of said common contact in response to change in power state of said readout circuit.

- 13. (Original) A system as in claim 11 wherein said controller in adjusting voltage potential of said common contact maintains a scanning circuit in an active state.
- 14. (Original) A system as in claim 11 wherein said readout circuit comprises a plurality of integrators determining charge across a plurality of photodiodes.
- 15. (Original) A system as in claim 14 wherein said controller adjusts voltage potential of said common contact in response to said charge.
- 16. (Currently Amended) A system—as in claim—11 An x-ray imaging system comprising:

a detector having a plurality of pixels comprising;

at least one data line; and

a common contact at a common contact voltage potential;

- a readout circuit electrically coupled to said at least one data line and having a plurality of power states; and
- a controller electrically coupled to said readout circuit, detecting a change in operating state of said readout circuit, and adjusting voltage potential of said common contact in response to said change in operating state;

wherein said readout circuit comprises:

- at least one integrator electrically coupled to said plurality of pixels; and
- a protection element electrically coupled to said integrator and conducting when said integrator is in a powered OFF state.
- 17. (Currently Amended) A system as in claim [[12]]16 wherein said protection element clamps voltage potential of at least one data line.
- 18. (Currently Amended) A system as in claim [[12]]16 wherein said controller detects said change and adjusts common contact voltage potential in response to power state of said integrator.
- 19. (Currently Amended) A system as in claim 11 An x-ray imaging system comprising:
 - a detector having a plurality of pixels comprising;
 - at least one data line; and
 - a common contact at a common contact voltage potential;
- a readout circuit electrically coupled to said at least one data line and having a plurality of power states; and
- a controller electrically coupled to said readout circuit, detecting a change in operating state of said readout circuit, and adjusting voltage potential of said common contact in response to said change in operating state;

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wherein said controller continuously adjusts common contact voltage potential to maintain an initial detector bias.

20. (Original) A system as in claim 11 wherein said controller enables x-ray image acquisition when voltage potential magnitude of an error signal is below a predetermined level.